

Dual N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

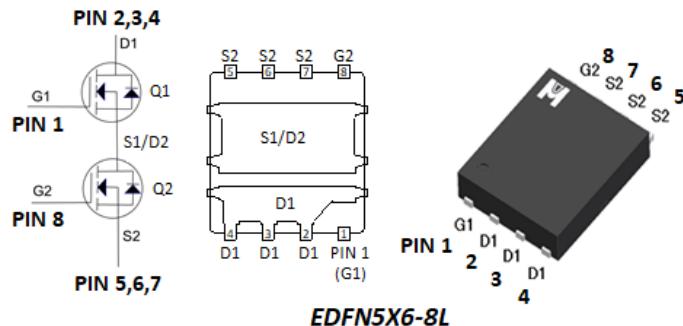
	Q1	Q2
BVDSS	30V	30V
R _{DS(on)} (MAX.) @ V _{GS} =10V	5.7mΩ	2.0mΩ
R _{DS(on)} (MAX.) @ V _{GS} =4.5V	8.8mΩ	2.8mΩ
I _D @ T _C =25°C	77A	172A
I _D @ T _A =25°C	16A	29A

Dual N Channel MOSFET

UIS, Rg 100% Tested

RoHS & Halogen Free & TSCA Compliant

Pin Description:



ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS		UNIT
		Q1	Q2	
Gate-Source Voltage	V _{GS}	±20	±12	V
Continuous Drain Current	T _C = 25 °C	77	172	
	T _C = 100 °C	48	126	
Continuous Drain Current	T _A = 25 °C	16	29	A
	T _A = 70 °C	12	23	
Pulsed Drain Current ¹	I _{DM}	136	384	
Avalanche Current	I _{AS}	70	100	
Avalanche Energy	EAS	24.5	50	mJ
Repetitive Avalanche Energy ²	EAR	122.5	250	
Power Dissipation	T _C = 25 °C	54	125	W
	T _C = 100 °C	22	50	
Power Dissipation	T _A = 25 °C	2.4	2.7	W
	T _A = 70 °C	1.5	1.7	
Operating Junction & Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

▪ 100% UIS testing in condition of VD=25V, L=0.01mH, VG=10V, IL=54A, RG=25Ω, Rated VDS=30V N-CH_Q1

▪ 100% UIS testing in condition of VD=25V, L=0.01mH, VG=10V, IL=70A, RG=25Ω, Rated VDS=30V N-CH_Q2

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM		UNIT
			Q1	Q2	
Junction-to-Case	R _{θJC}		2.3	1.0	°C/W
Junction-to-Top	R _{θJT}		42	30	
Junction-to-Ambient ³	t ≤ 10s	R _{θJA}	23	18	
	Steady-State	R _{θJA}	53	46	

¹Pulse width limited by maximum junction temperature.

²Duty cycle < 1%

³The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.

⁴Guarantee by Engineering test



▪ Q1_ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage ⁴	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage ⁴	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.6	2.5	
Gate-Body Leakage ⁴	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 100	nA
Zero Gate Voltage Drain Current ⁴	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$			1	μA
		$V_{DS} = 30V, V_{GS} = 0V, T_J = 125^\circ\text{C}$			25	
On-State Drain Current ¹	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	77			A
Drain-Source On-State Resistance ^{1,4}	$R_{DS(\text{ON})}$	$V_{GS} = 10V, I_D = 20\text{A}$		4.2	5.7	$\text{m}\Omega$
		$V_{GS} = 4.5V, I_D = 20\text{A}$		6.0	8.8	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 15\text{A}$		50		S
DYNAMIC						
Input Capacitance ⁵	C_{iss}	$V_{GS} = 0V, V_{DS} = 15V, f = 1\text{MHz}$		830		pF
Output Capacitance ⁵	C_{oss}			330		
Reverse Transfer Capacitance ⁵	C_{rss}			40		
Gate Resistance ^{4,5}	R_g	$f = 1\text{MHz}$		0.7		Ω
Total Gate Charge ^{1,2,5}	$Q_g(V_{GS}=10V)$	$V_{DS} = 15V, V_{GS} = 10V, I_D = 20\text{A}$		15		nC
	$Q_g(V_{GS}=4.5V)$			6.9		
Gate-Source Charge ^{1,2,5}	Q_{gs}			3.3		
Gate-Drain Charge ^{1,2,5}	Q_{gd}			1.8		
Turn-On Delay Time ^{1,2,5}	$t_{d(on)}$			5.8		nS
Rise Time ^{1,2,5}	t_r	$V_{DS} = 15V, V_{GS} = 10V, I_D = 5\text{A}, R_g = 3\Omega$		11		
Turn-Off Delay Time ^{1,2,5}	$t_{d(off)}$			14		
Fall Time ^{1,2,5}	t_f			3.1		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				45	A
Pulsed Current ³	I_{SM}				136	
Forward Voltage ^{1,4}	V_{SD}	$I_F = 20\text{A}, V_{GS} = 0V$			1.2	V
Reverse Recovery Time ⁵	t_{rr}	$I_F = 20\text{A}, dI_F/dt = 400\text{A}/\mu\text{s}$		12		nS
Peak Reverse Recovery Current ⁵	$I_{RM(\text{REC})}$			2.1		A
Reverse Recovery Charge ⁵	Q_{rr}			13		nC

¹Pulse test : Pulse Width ≤ 300 usec, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

⁴Guarantee by FT test Item

⁵Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.

-Q1_TYPICAL CHARACTERISTICS

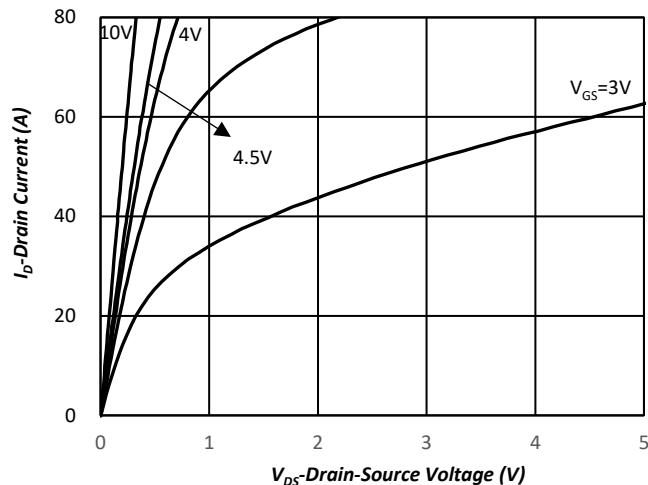


Fig.1 Typical Output Characteristics

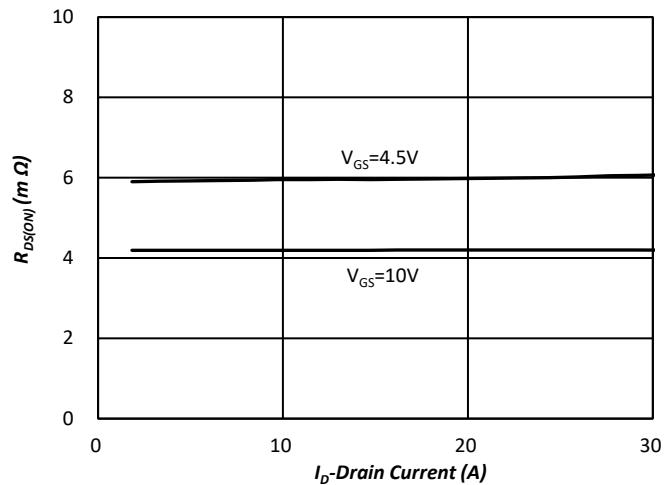


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

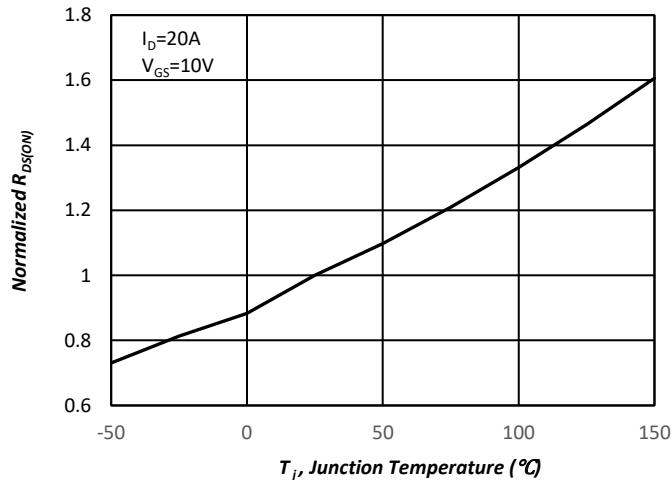


Fig.3 Normalized On-Resistance v.s. Junction Temperature

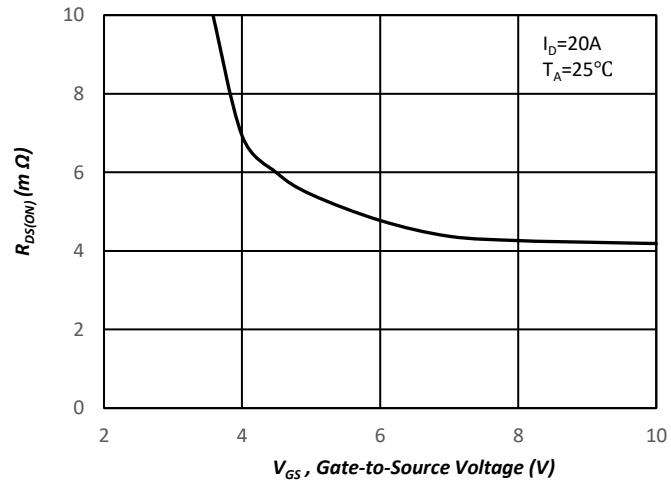


Fig.4 On-Resistance v.s. Gate Voltage

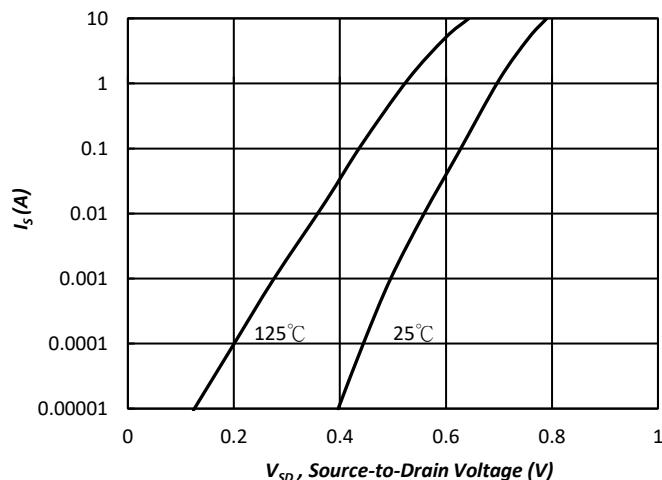


Fig.5 Forward Characteristic of Reverse Diode

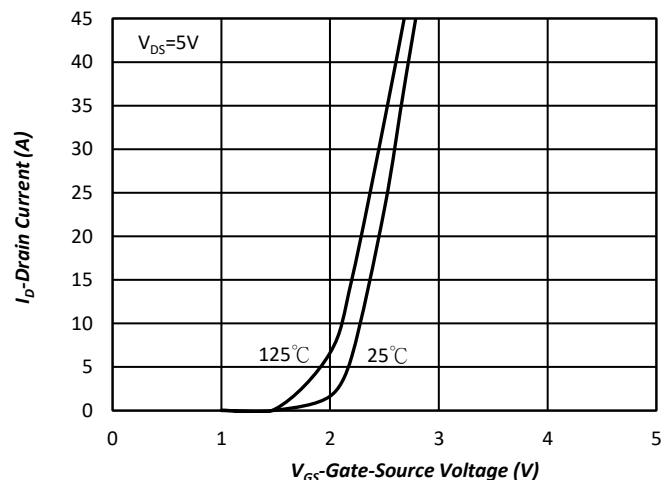
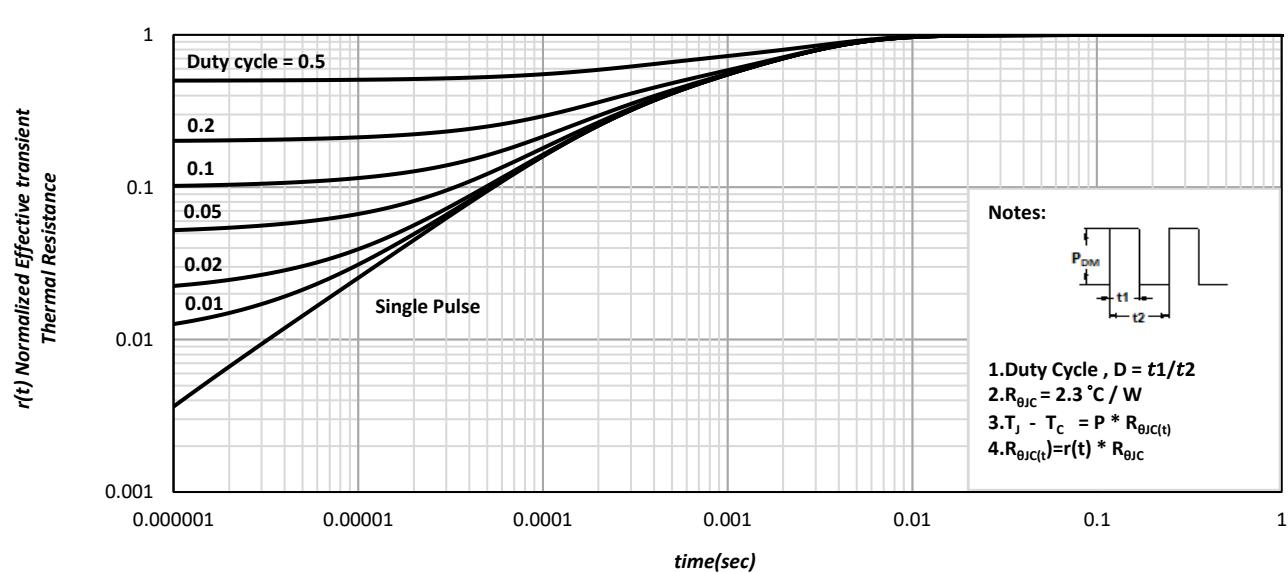
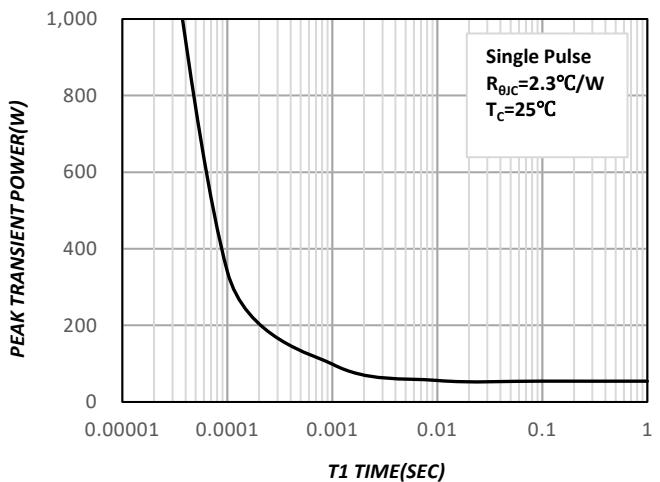
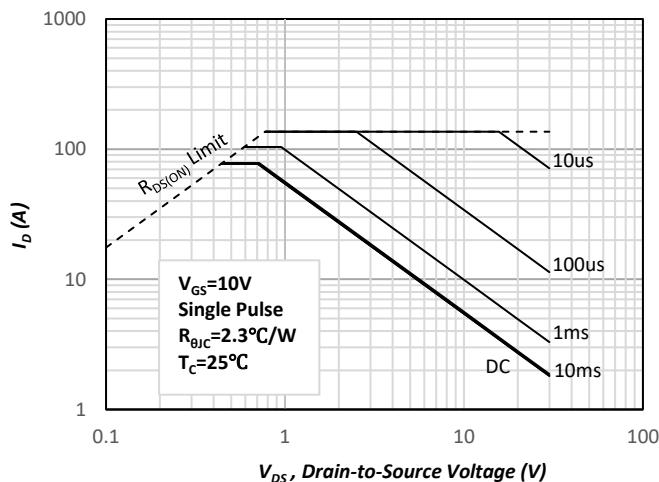
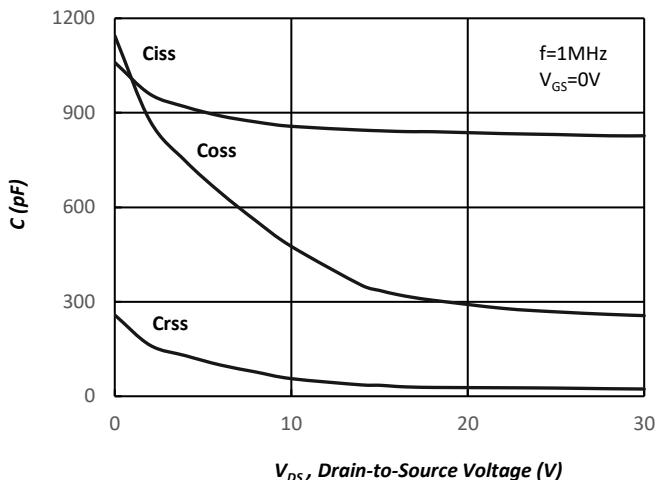
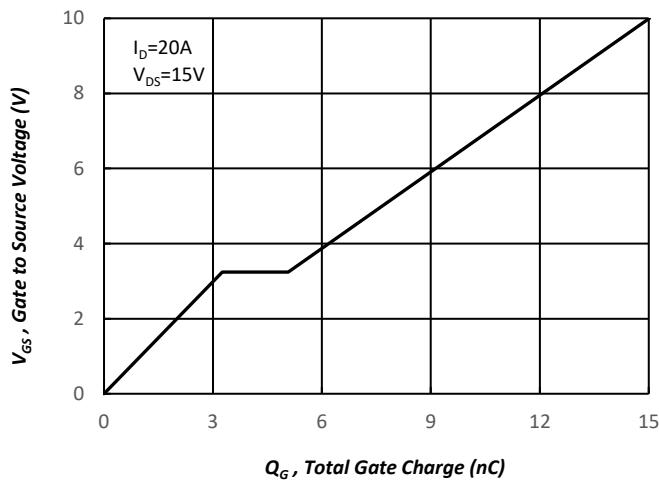


Fig.6 Transfer Characteristics





▪ Q2_ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage ⁴	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage ⁴	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.2	1.6	2.5	
Gate-Body Leakage ⁴	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 12V$			± 100	nA
Zero Gate Voltage Drain Current ⁴	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$			1	μA
		$V_{DS} = 30V, V_{GS} = 0V, T_J = 125^\circ\text{C}$			25	
On-State Drain Current ¹	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	172			A
Drain-Source On-State Resistance ^{1,4}	$R_{DS(\text{ON})}$	$V_{GS} = 10V, I_D = 20\text{A}$		1.5	2.0	$\text{m}\Omega$
		$V_{GS} = 4.5V, I_D = 20\text{A}$		2.1	2.8	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 15\text{A}$		110		S
DYNAMIC						
Input Capacitance ⁵	C_{iss}	$V_{GS} = 0V, V_{DS} = 15V, f = 1\text{MHz}$		2470		pF
Output Capacitance ⁵	C_{oss}			830		
Reverse Transfer Capacitance ⁵	C_{rss}			55		
Gate Resistance ^{4,5}	R_g	$f = 1\text{MHz}$		0.8		Ω
Total Gate Charge ^{1,2,5}	$Q_g(V_{GS}=10V)$	$V_{DS} = 15V, V_{GS} = 10V, I_D = 20\text{A}$		45		nC
	$Q_g(V_{GS}=4.5V)$			20		
Gate-Source Charge ^{1,2,5}	Q_{gs}			8.2		
Gate-Drain Charge ^{1,2,5}	Q_{gd}			4.1		
Turn-On Delay Time ^{1,2,5}	$t_{d(on)}$			9.9		nS
Rise Time ^{1,2,5}	t_r	$V_{DS} = 15V, V_{GS} = 10V, I_D = 5\text{A}, R_g = 3\Omega$		13		
Turn-Off Delay Time ^{1,2,5}	$t_{d(off)}$			33		
Fall Time ^{1,2,5}	t_f			8.2		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				104	A
Pulsed Current ³	I_{SM}				384	
Forward Voltage ^{1,4}	V_{SD}	$I_F = 20\text{A}, V_{GS} = 0V$			1.2	V
Reverse Recovery Time ⁵	t_{rr}	$I_F = 20\text{A}, dI_F/dt = 400\text{A}/\mu\text{s}$		29		nS
Peak Reverse Recovery Current ⁵	$I_{RM(\text{REC})}$			3.3		A
Reverse Recovery Charge ⁵	Q_{rr}			47		nC

¹Pulse test : Pulse Width ≤ 300 usec, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

⁴Guarantee by FT test Item

⁵Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.



-Q2_TYPICAL CHARACTERISTICS

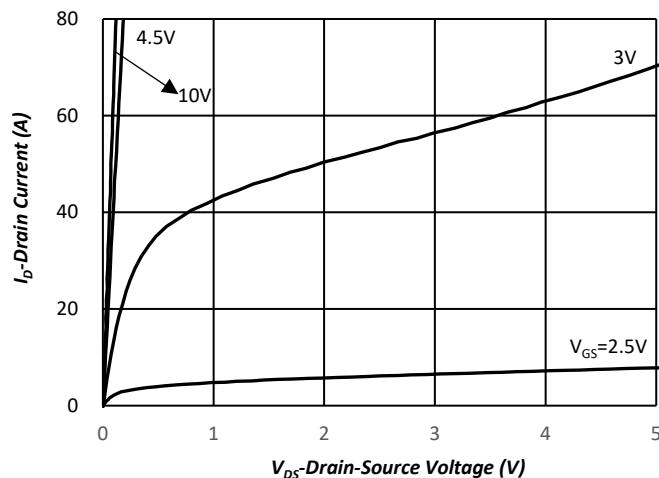


Fig.1 Typical Output Characteristics

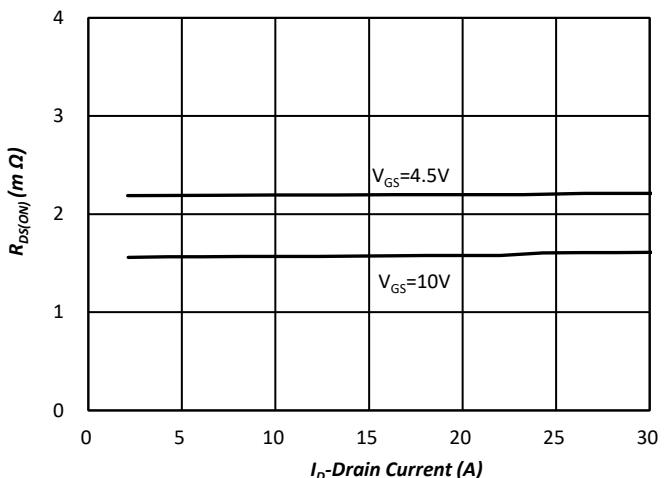


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

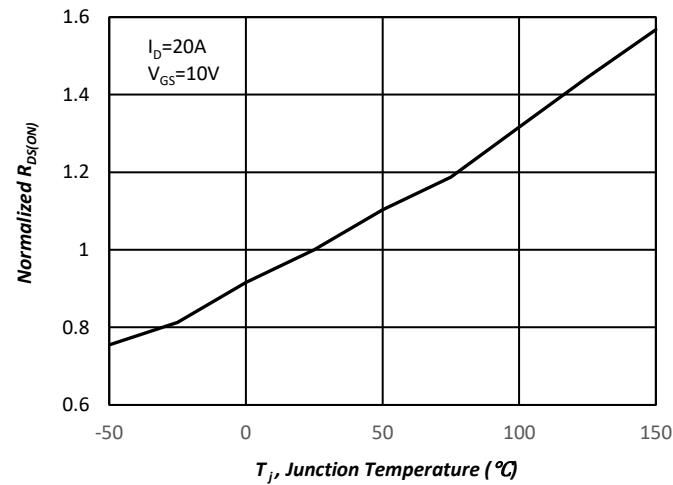


Fig.3 Normalized On-Resistance v.s. Junction Temperature

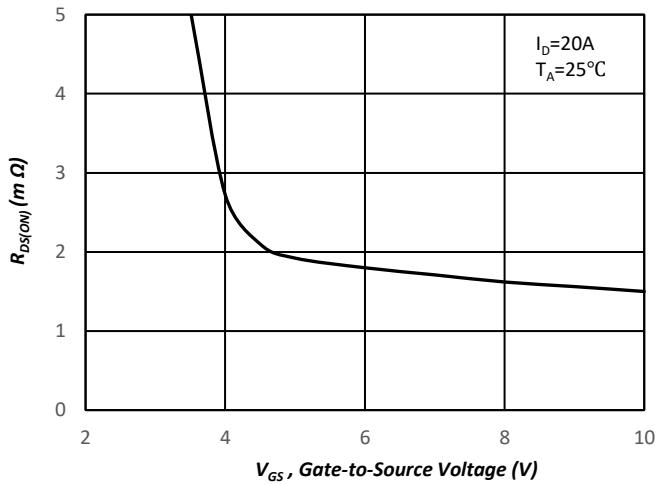


Fig.4 On-Resistance v.s. Gate Voltage

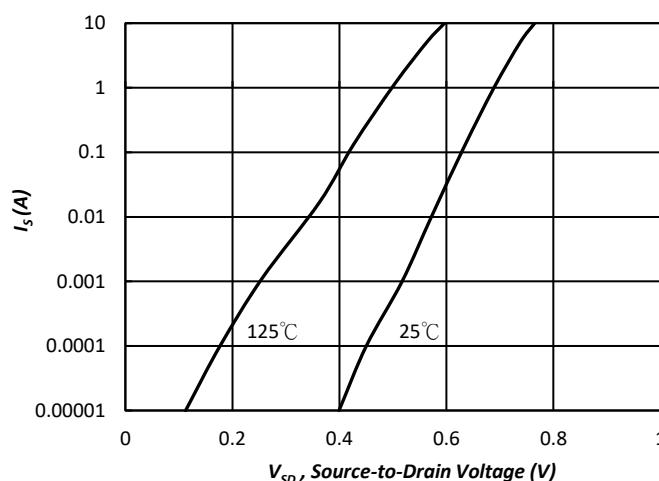


Fig.5 Forward Characteristic of Reverse Diode

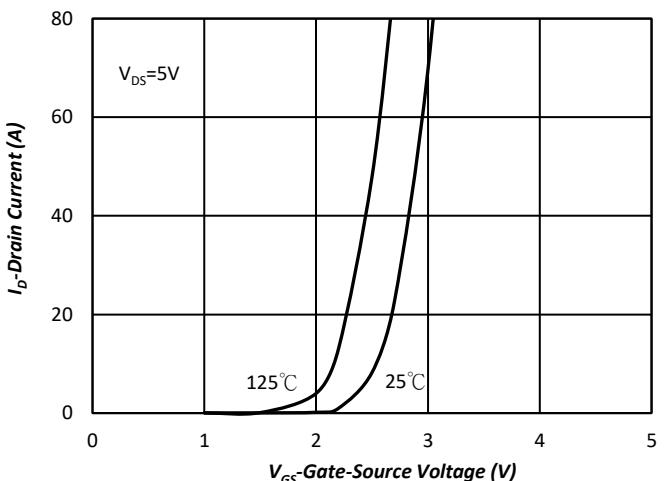


Fig.6 Transfer Characteristics

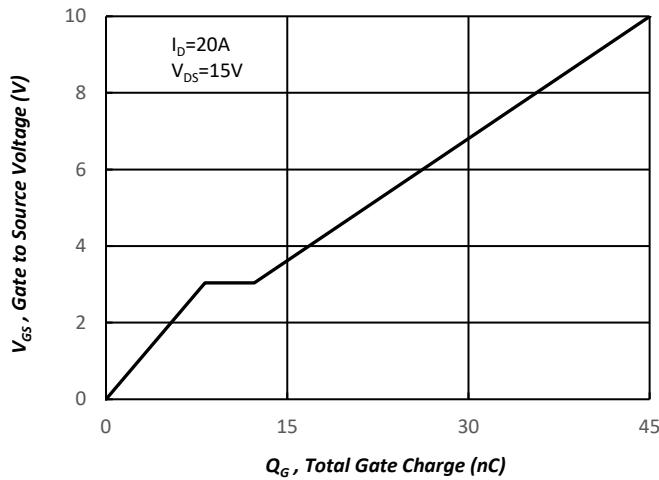


Fig.7 Gate Charge Characteristics

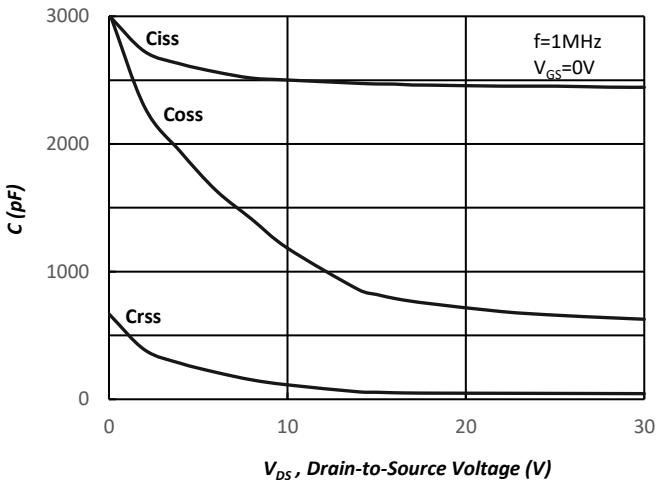


Fig.8 Typical Capacitance Characteristics

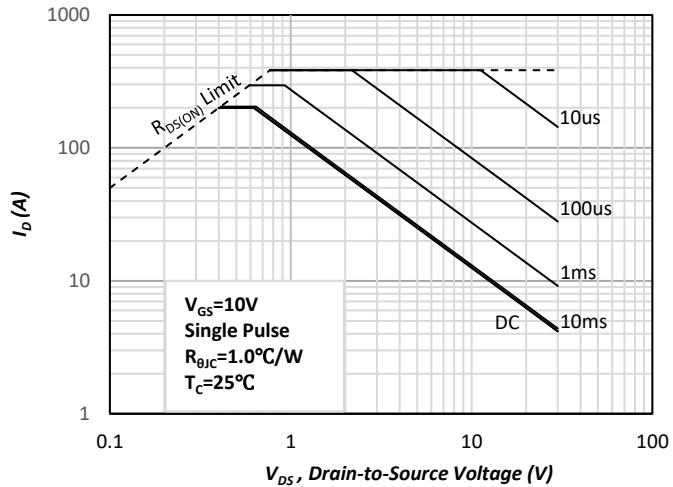


Fig.9. Maximum Safe Operating Area

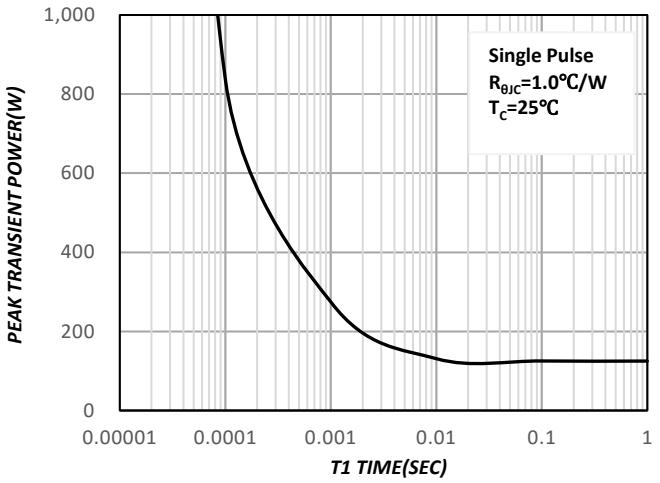


Fig 10. Single Pulse Maximum Power Dissipation

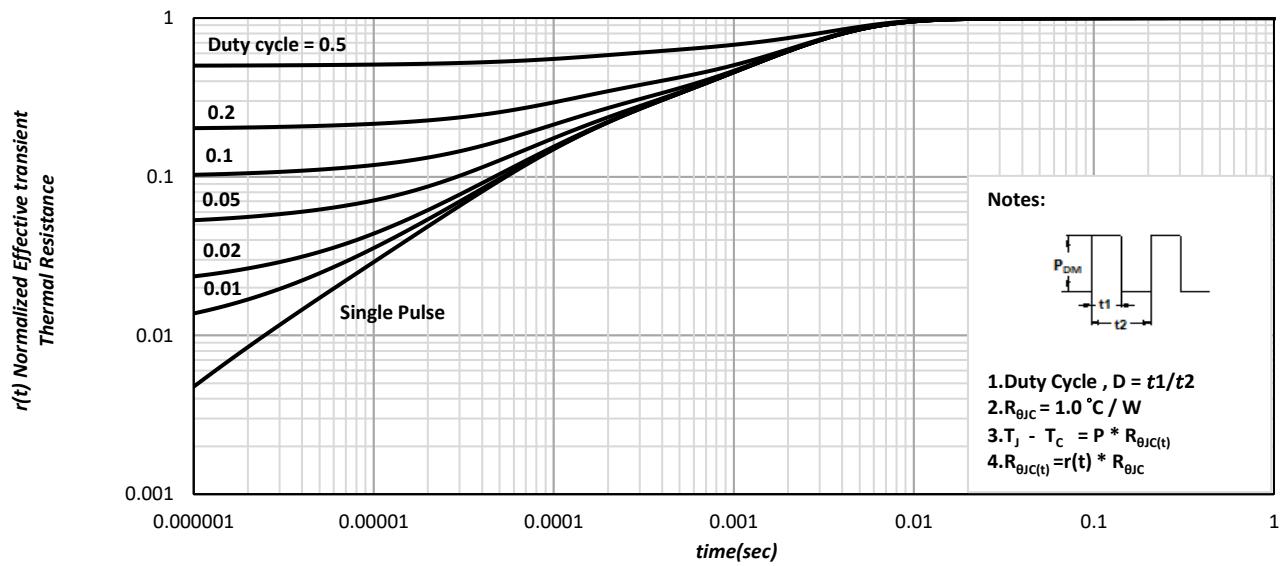
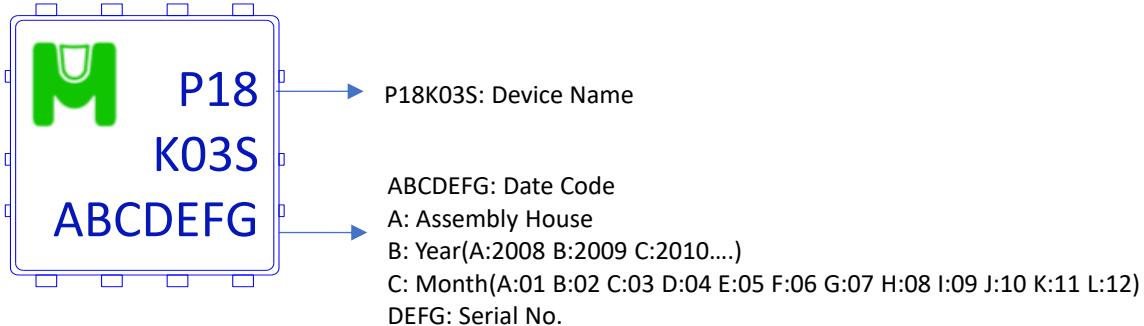


Fig 11. Effective Transient Thermal Impedance

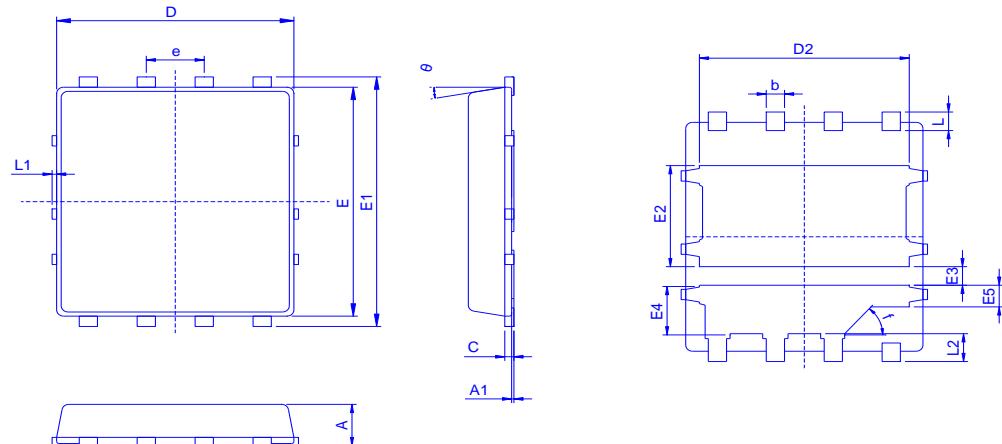


Ordering & Marking Information:

Device Name: EMP18K03HPCS for Asymmetric EDFN5X6-8L



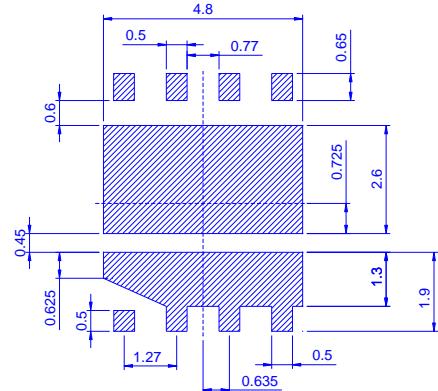
Outline Drawing



Dimension	A	A1	b	c	D	D2	E	E1	E2	E3	E4	E5	e
Min.	0.85	-	0.33	0.15	4.80	3.61	5.55	5.90	2.02	0.40	1.10	0.48	-
Typ.	0.90	-	0.40	0.20	4.90	3.81	5.65	6.00	2.17	0.45	1.18	0.53	1.27
Max.	1.10	0.05	0.51	0.30	5.40	4.70	5.80	6.10	2.50	0.60	1.42	0.58	-

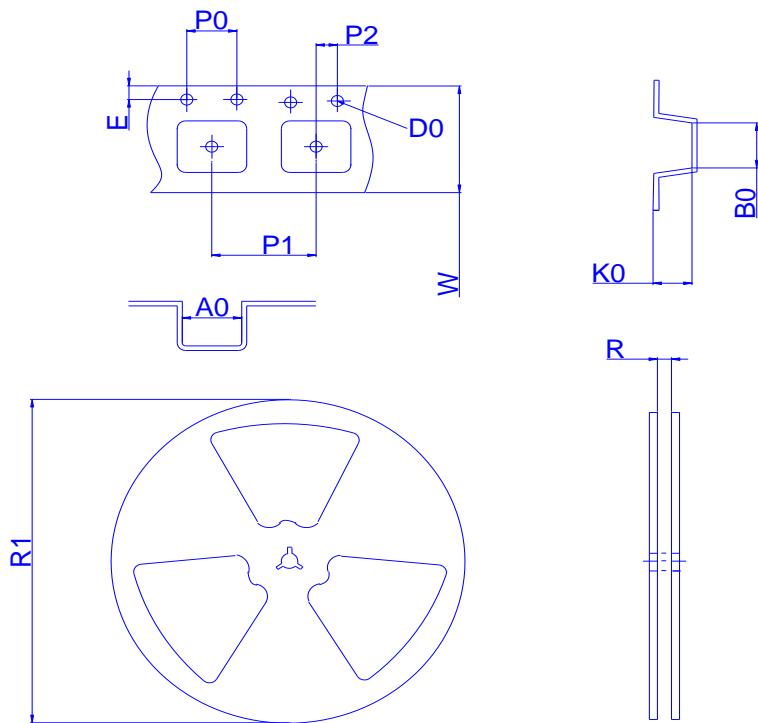
Dimension	L	L1	L2	θ
Min.	0.35	-	0.48	0°
Typ.	0.45	-	0.58	
Max.	0.71	0.10	0.81	12°

Footprint





◆ Tape&Reel Information: 2500pcs/Reel



Package	EDFN5X6-8L
Reel	13"
Device orientation	FEED DIRECTION →

Dimension in mm

Dimension	Carrier tape								W	Reel	
	A0	B0	D0	E	K0	P0	P1	P2		R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4	8	2	12	12.4	330
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2	2